Power MOSFET and Schottky Diode

–20 V, FETKY[™], P–Channel, –4.4 A, with 4.1 A Schottky Barrier Diode, ChipFET[™]

Features

- Leadless SMD Package Featuring a MOSFET and Schottky Diode
- 40% Smaller than TSOP-6 Package
- Leadless SMD Package Provides Great Thermal Characteristics
- Independent Pinout to each Device to Ease Circuit Design
- Trench P-Channel for Low On Resistance
- Ultra Low V_F Schottky
- Pb-Free Packages are Available

Applications

- Li–Ion Battery Charging
- High Side DC–DC Conversion Circuits
- High Side Drive for Small Brushless DC Motors
- Power Management in Portable, Battery Powered Products

MOSFET MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Param	Symbol	Value	Units				
Drain-to-Source Voltag	V _{DSS}	-20	V				
Gate-to-Source Voltage	e		V _{GS}	±8.0	V		
Continuous Drain	Steady	$T_J = 25^{\circ}C$	I _D	-3.2	А		
Current (Note 1)	State	$T_J = 85^{\circ}C$		-2.3			
	t ≤ 5 s	$T_J = 25^{\circ}C$		-4.4			
Power Dissipation (Note 1)	Steady State	,		1.1	W		
	t ≤ 5 s			2.1			
Pulsed Drain Current	t _p =	10 μs	I _{DM}	-13	А		
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C		
Source Current (Body Diode)			۱ _S	2.5	А		
Lead Temperature for S (1/8" from case for 1		urposes	ΤL	260	°C		

SCHOTTKY DIODE MAXIMUM RATINGS

(T_J = 25°C unless otherwise noted)

Para	Symbol	Value	Units		
Peak Repetitive Rever	V _{RRM}	20	V		
DC Blocking Voltage	V _R	20	V		
Average Rectified Forward Current	Steady State	T _J = 25°C	١ _F	2.2	V
	t≤5s			4.1	А

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

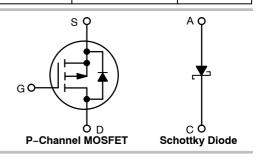
1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

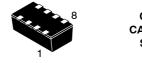


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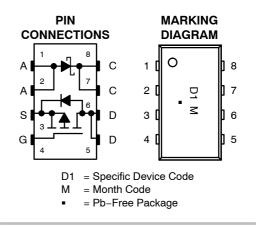
http://onsemi.com

MOSFET						
V _{(BR)DSS} R _{DS(on)} TYP I _D MAX						
00.1/	64 mΩ @ -4.5 V					
–20 V	85 mΩ @ –2.5 V	-4.4 A				
	SCHOTTKY DIODE					
V _R MAX	V _F TYP	I _F MAX				
20 V	0.510 V	4.1 A				





ChipFET CASE 1206A STYLE 3



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	113	°C/W
Junction-to-Ambient – t \leq 10 s (Note 2)	$R_{ hetaJA}$	60	°C/W

2. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

MOSFET ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

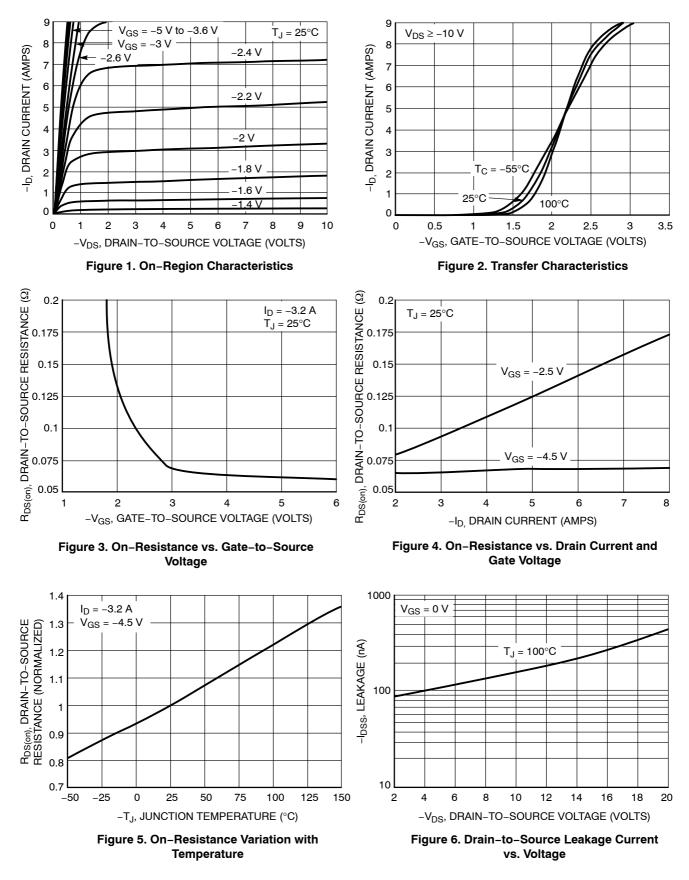
Parameter	Symbol	Test Condition	IS	Min	Тур	Max	Units
OFF CHARACTERISTICS				1			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = -25	50 μA	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				-15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -16 V, V _{GS} = 0 V	$T_J = 25^{\circ}C$			-1.0	μΑ
			$1_{\rm J} = 125^{\circ}{\rm C}$			-5.0	
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} = ±	8.0 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -28$	50 μΑ	-0.45		-1.5	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				2.7		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = -4.5, I_D = -3$	3.2 A		64	80	mΩ
		$V_{GS} = -2.5, I_D = -2.5$	2.2 A		85	110	1
		V _{GS} = -1.8, I _D = - ⁻	1.0 A		120	170	
Forward Transconductance	9 _{FS}	V _{DS} = -10 V, I _D = -2.9 A			8.0		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -10 V			680		pF
Output Capacitance	C _{OSS}				100		
Reverse Transfer Capacitance	C _{RSS}	103 101			70		
Total Gate Charge	Q _{G(TOT)}				7.4		nC
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = -4.5 V, V_{DS} = I_{D} = -3.2 A	–10 V,		0.6		
Gate-to-Source Charge	Q _{GS}	I _D = -3.2 A			1.4		
Gate-to-Drain Charge	Q _{GD}				2.5		
SWITCHING CHARACTERISTICS (No	ote 4)						
Turn-On Delay Time	t _{d(ON)}				5.8		ns
Rise Time	t _r	V _{GS} = -4.5 V, V _{DD} =	–10 V,		11.7		
Turn-Off Delay Time	t _{d(OFF)}	$I_{\rm D} = -3.2$ A, $R_{\rm G} = 2$	2.4 Ω		16		-
Fall Time	t _f				12.4		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = -2.5 \text{ A}$	T _J = 25°C		-0.8	-1.2	V
Reverse Recovery Time	t _{RR}				13.5		ns
Charge Time	ta	V_{GS} = 0 V, I_S = –1.0 A , dI_S/dt = 100 A/µs			9.5		1
Discharge Time	t _b				4.0		1
Reverse Recovery Charge	Q _{RR}				6.5		nC
SCHOTTKY DIODE ELECTRICAL		RISTICS (T _J = 25°C unless	s otherwise not	ed)			
Parameter	Symbol	Test Condition	IS	Min	Тур	Max	Units
Maximum Instantaneous	VE	I⊏ = 0.1 A			0.425		V

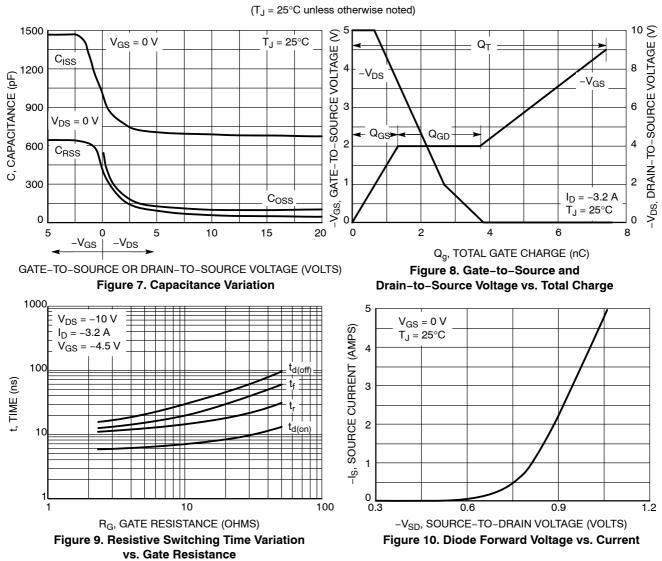
i alameter	Gymbol	rest oblightions	 i yp	INIGA	Onits
Maximum Instantaneous	V _F	I _F = 0.1 A	0.425		V
Forward Voltage		I _F = 1.0 A	0.510	0.575	
Maximum Instantaneous	I _R	V _R = 10 V		1.0	μΑ
Reverse Current		V _R = 20 V		5.0	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL P-CHANNEL PERFORMANCE CURVES

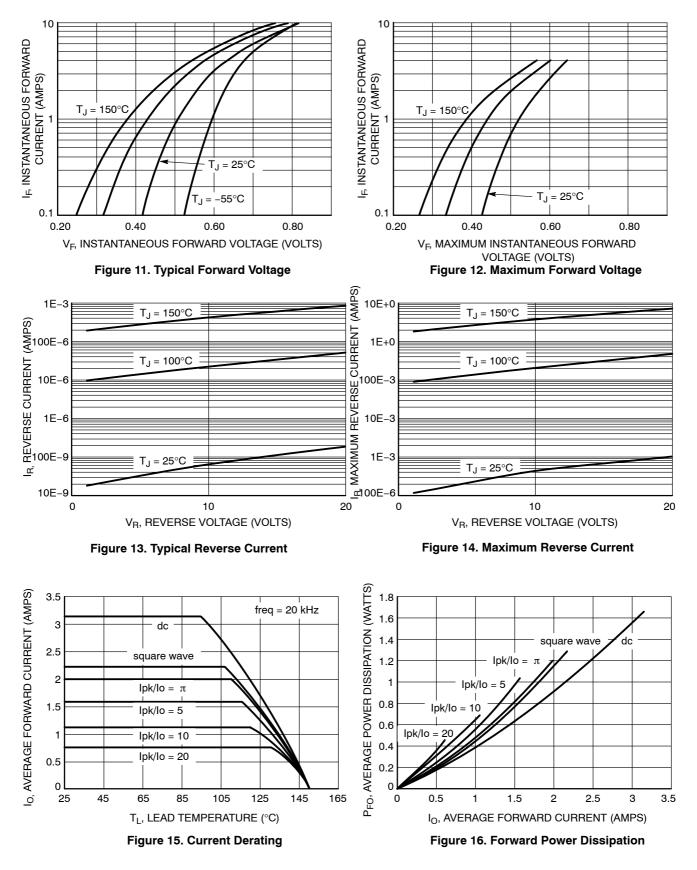
 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$





TYPICAL P-CHANNEL PERFORMANCE CURVES

TYPICAL SCHOTTKY PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



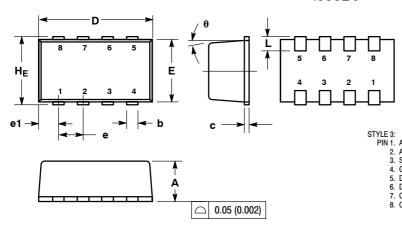
DEVICE ORDERING INFORMATION

Device	Package	Shipping [†]
NTHD3101FT1	ChipFET	3000 / Tape & Reel
NTHD3101FT1G	ChipFET (Pb-Free)	3000 / Tape & Reel
NTHD3101FT3	ChipFET	10000 / Tape & Reel
NTHD3101FT3G	ChipFET (Pb-Free)	10000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

ChipFET CASE 1206A-03 **ISSUE J**



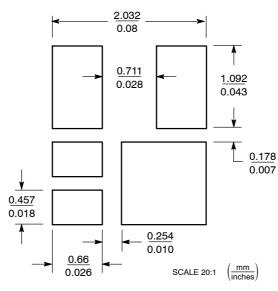
NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM. 2 З. 4.

DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD 5 6 SURFACE

		м	ILLIMETE	INCHES				
	DIM	MIN	NOM	MAX	MIN	NOM	MAX	
	Α	1.00	1.05	1.10	0.039	0.041	0.043	
	b	0.25	0.30	0.35	0.010	0.012	0.014	
A	С	0.10	0.15	0.20	0.004	0.006	0.008	
A	D	2.95	3.05	3.10	0.116	0.120	0.122	
5	Е	1.55	1.65	1.70	0.061	0.065	0.067	
3	е		0.65 BSC		0.025 BSC			
2	e1		0.55 BSC			0.022 BSC	;	
5	L	0.28	0.35	0.42	0.011	0.014	0.017	
5	ΗE	1.80	1.90	2.00	0.071	0.075	0.079	
,	θ		5° NOM					

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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